

January 2008

# 74AC299, 74ACT299 8-Input Universal Shift/Storage Register with Common Parallel I/O Pins

## Features

- I<sub>CC</sub> and I<sub>OZ</sub> reduced by 50%
- Common parallel I/O for reduced pin count
- Additional serial inputs and outputs for expansion
- Four operating modes: shift left, shift right, load and store
- 3-STATE outputs for bus-oriented applications
- Outputs source/sink 24mA
- ACT299 has TTL-compatible inputs

# **General Description**

The AC/ACT299 is an 8-bit universal shift/storage register with 3-STATE outputs. Four modes of operation are possible: hold (store), shift left, shift right and load data. The parallel load inputs and flip-flop outputs are multiplexed to reduce the total number of package pins. Additional outputs are provided for flip-flops  $Q_0$ ,  $Q_7$  to allow easy serial cascading. A separate active LOW Master Reset is used to reset the register.

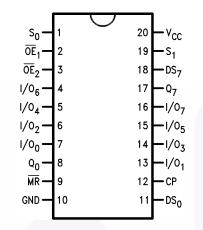
# **Ordering Information**

Order Number	Package Number	Package Description
74AC299SC	M20B	20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300" Wide
74AC299SJ	M20D	20-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
74AC299MTC	MTC20	20-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide
74AC299PC	N20A	20-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide
74ACT299SC	M20B	20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300" Wide
74ACT299MTC	MTC20	20-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide
74ACT299PC	N20A	20-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide

Device also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering number.

All packages are lead free per JEDEC: J-STD-020B standard.

# **Connection Diagram**



## **Pin Description**

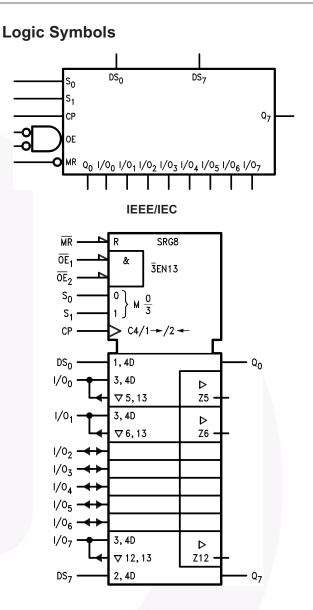
Clock Pulse Input
Serial Data Input for Right Shift
Serial Data Input for Left Shift
Mode Select Inputs
Asynchronous Master Reset
3-STATE Output Enable Inputs
Parallel Data Inputs or 3-STATE Parallel Outputs
Serial Outputs

## **Functional Description**

The AC/ACT299 contains eight edge-triggered D-type flip-flops and the interstage logic necessary to perform synchronous shift left, shift right, parallel load and hold operations. The type of operation is determined by  $S_0$  and  $S_1$ , as shown in the Truth Table. All flip-flop outputs are brought out through 3-STATE buffers to separate I/O pins that also serve as data inputs in the parallel load mode.  $Q_0$  and  $Q_7$  are also brought out on other pins for expansion in serial shifting of longer words.

A LOW signal on  $\overline{\text{MR}}$  overrides the Select and CP inputs and resets the flip-flops. All other state changes are initiated by the rising edge of the clock. Inputs can change when the clock is in either state provided only that the recommended setup and hold times, relative to the rising edge of CP, are observed.

A HIGH signal on either  $\overline{OE}_1$  or  $\overline{OE}_2$  disables the 3-STATE buffers and puts the I/O pins in the high impedance state. In this condition the shift, hold, load and reset operations can still occur. The 3-STATE buffers are also disabled by HIGH signals on both S<sub>0</sub> and S<sub>1</sub> in preparation for a parallel load operation.



## **Truth Table**

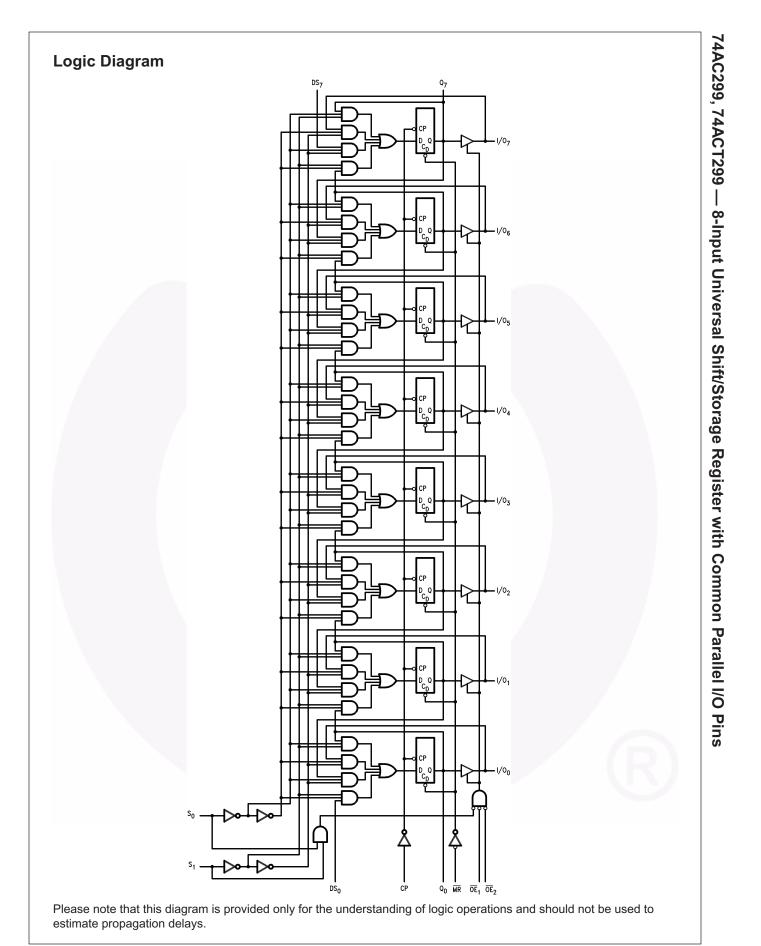
	Inp	uts		Response
MR	<b>S</b> <sub>1</sub>	S <sub>0</sub>	СР	
L	Х	Х	Х	Asynchronous Reset; $Q_0-Q_7 = LOW$
Н	Н	Н	~	Parallel Load; I/O <sub>n</sub> $\rightarrow$ Q <sub>n</sub>
Н	L	Н	~	Shift Right; $DS_0 \rightarrow Q_0, Q_0 \rightarrow Q_1$ , etc.
Н	Η	L	~	Shift Left, $DS_7 \rightarrow Q_7, Q_7 \rightarrow Q_6$ , etc.
Н	L	L	Х	Hold

H = HIGH Voltage Level

L = LOW Voltage Level

X = Immaterial

LOW-to-HIGH Transition



# **Absolute Maximum Ratings**

Stresses exceeding the absolute maximum ratings may damage the device. The device may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only.

Symbol	Parameter	Rating
V <sub>CC</sub>	Supply Voltage	-0.5V to +7.0V
I <sub>IK</sub>	DC Input Diode Current	
	$V_{I} = -0.5V$	–20mA
	$V_{I} = V_{CC} + 0.5$	+20mA
VI	DC Input Voltage	-0.5V to V <sub>CC</sub> + 0.5V
I <sub>OK</sub>	DC Output Diode Current	
	$V_{O} = -0.5V$	–20mA
	$V_{O} = V_{CC} + 0.5V$	+20mA
Vo	DC Output Voltage	-0.5V to V <sub>CC</sub> + 0.5V
Ι <sub>Ο</sub>	DC Output Source or Sink Current	±50mA
I <sub>CC</sub> or I <sub>GND</sub>	DC V <sub>CC</sub> or Ground Current per Output Pin	±50mA
T <sub>STG</sub>	Storage Temperature	-65°C to +150°C
TJ	Junction Temperature	140°C

# **Recommended Operating Conditions**

The Recommended Operating Conditions table defines the conditions for actual device operation. Recommended operating conditions are specified to ensure optimal performance to the datasheet specifications. Fairchild does not recommend exceeding them or designing to absolute maximum ratings.

Symbol	Parameter	Rating
V <sub>CC</sub>	Supply Voltage (unless otherwise specified)	
	AC	2.0V to 6.0V
	ACT	4.5V to 5.5V
VI	Input Voltage	0V to V <sub>CC</sub>
Vo	Output Voltage	0V to V <sub>CC</sub>
T <sub>A</sub>	Operating Temperature	-40°C to +85°C
$\Delta V / \Delta t$	Minimum Input Edge Rate, AC Devices:	125mV/ns
	$V_{\rm IN}$ from 30% to 70% of $V_{\rm CC}, V_{\rm CC}$ @ 3.3V, 4.5V, 5.5V	
$\Delta V / \Delta t$	Minimum Input Edge Rate, ACT Devices:	125mV/ns
	$V_{\rm IN}$ from 0.8V to 2.0V, $V_{\rm CC}$ @ 4.5V, 5.5V	

				$T_A = +$	⊦25°C	$T_A = -40^{\circ}C \text{ to } +85^{\circ}C$	
Symbol	Parameter	V <sub>CC</sub> (V)	Conditions	Тур.	G	uaranteed Limits	Units
V <sub>IH</sub>	Minimum HIGH Level	3.0	$V_{OUT} = 0.1V \text{ or}$	1.5	2.1	2.1	V
	Input Voltage	4.5	V <sub>CC</sub> – 0.1V	2.25	3.15	3.15	
	V <sub>II</sub> Maximum LOW Level			2.75	3.85	3.85	1
V <sub>IL</sub>	Maximum LOW Level	3.0	$V_{OUT} = 0.1V$ or	1.5	0.9	0.9	V
	Input Voltage	4.5	V <sub>CC</sub> – 0.1V	2.25	1.35	1.35	1
		5.5		2.75	1.65	1.65	1
V <sub>OH</sub>	Minimum HIGH Level	3.0	I <sub>OUT</sub> =50μA	2.99	2.9	2.9	V
	Output Voltage	4.5		4.49	4.4	4.4	1
		5.5		5.49	5.4	5.4	
		3.0	$V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OH} = -12 \text{mA}$		2.56	2.46	
		4.5	$V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OH} = -24 \text{mA}$		3.86	3.76	
		5.5	$V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OH} = -24 \text{mA}^{(1)}$		4.86	4.76	
V <sub>OL</sub>	Maximum LOW Level		0 Ι <sub>ΟUT</sub> = 50μΑ	0.002	0.1	0.1	V
	Output Voltage	4.5		0.001	0.1	0.1	
		5.5		0.001	0.1	0.1	
		3.0	$V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OL} = 12 \text{mA}$		0.36	0.44	
		4.5	$V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OL} = 24 \text{mA}$		0.36	0.44	
		5.5	$V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OL} = 24 \text{mA}^{(1)}$		0.36	0.44	
I <sub>IN</sub> <sup>(2)</sup>	Maximum Input Leakage Current	5.5	$V_I = V_{CC}$ , GND		±0.1	±1.0	μA
I <sub>OLD</sub>	Minimum Dynamic	5.5	V <sub>OLD</sub> = 1.65V Max.			75	mA
I <sub>OHD</sub>	Output Current <sup>(3)</sup>	5.5	V <sub>OHD</sub> = 3.85V Min.			-75	mA
I <sub>CC</sub> <sup>(2)</sup>	Maximum Quiescent Supply Current	5.5	$V_{IN} = V_{CC}$ or GND		4.0	40.0	μA
I <sub>OZT</sub>	Maximum I/O Leakage Current	5.5			±0.3	±3.0	μA

## **DC Electrical Characteristics for AC**

## Notes:

1. All outputs loaded; thresholds on input associated with output under test.

2. I<sub>IN</sub> and I<sub>CC</sub> @ 3.0V are guaranteed to be less than or equal to the respective limit @ 5.5V V<sub>CC</sub>.

3. Maximum test duration 2.0ms, one output loaded at a time.

				<b>T</b> <sub>A</sub> = +	-25°C	$T_A = -40^{\circ}C \text{ to } +85^{\circ}C$	
Symbol	Parameter	V <sub>CC</sub> (V)	Conditions	Тур.	G	uaranteed Limits	Units
V <sub>IH</sub>	Minimum HIGH Level	4.5	$V_{OUT} = 0.1V \text{ or}$	1.5	2.0	2.0	V
	Input Voltage	5.5	V <sub>CC</sub> – 0.1V	1.5	2.0	2.0	
V <sub>IL</sub>	Maximum LOW	4.5	$V_{OUT} = 0.1V$ or	1.5	0.8	0.8	V
	Level Input Voltage	5.5	V <sub>CC</sub> – 0.1V	1.5	0.8	0.8	
V <sub>OH</sub>	Minimum HIGH Level	4.5	Ι <sub>ΟUT</sub> = -50μΑ	4.49	4.4	4.4	V
	Output Voltage	5.5		5.49	5.4	5.4	
		4.5	$V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OH} = -24 \text{mA}$	0.0001	3.86	3.76	
		5.5	$V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OH} = -24 \text{mA}^{(4)}$		4.86	4.76	
V <sub>OL</sub>	Maximum LOW Level Output Voltage	4.5	Ι <sub>ΟUT</sub> = 50μΑ	0.001	0.1	0.1	V
		5.5		0.001	0.1	0.1	1
		4.5	$V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OL} = 24 \text{mA}$		0.36	0.44	
		5.5	$V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OL} = 24 \text{mA}^{(4)}$		0.36	0.44	
I <sub>IN</sub>	Maximum Input Leakage Current	5.5	$V_I = V_{CC}, GND$		±0.1	±1.0	μA
I <sub>CCT</sub>	Maximum I <sub>CC</sub> /Input	5.5	$V_I = V_{CC} - 2.1V$	0.6		1.5	mA
I <sub>OLD</sub>	Minimum Dynamic	5.5	V <sub>OLD</sub> = 1.65V Max.			75	mA
I <sub>OHD</sub>	Output Current <sup>(5)</sup>	5.5	V <sub>OHD</sub> = 3.85V Min.			-75	mA
I <sub>CC</sub>	Maximum Quiescent Supply Current	5.5	$V_{IN} = V_{CC}$ or GND		4.0	40.0	μA
I <sub>OZT</sub>	Maximum I/O Leakage Current	5.5			±0.3	±3.0	μA

## Notes:

4. All outputs loaded; thresholds on input associated with output under test.

5. Maximum test duration 2.0ms, one output loaded at a time.

		V <sub>CC</sub> (V) <sup>(6)</sup>	T <sub>A</sub> = +25°C, C <sub>L</sub> = 50pF				C to +85°C, 50pF	
Symbol	Parameter		Min.	Тур.	Max.	Min.	Max.	Units
f <sub>MAX</sub>	Maximum Input Frequency	3.3	90	124		80		MHz
		5.0	130	173		105		
t <sub>PLH</sub>	Propagation Delay, CP to $Q_0$ or $Q_7$	3.3	8.5	14.0	20.5	7.0	22.0	ns
(Shift Left or Right)	5.0	5.5	9.5	14.0	4.5	15.0		
t <sub>PHL</sub>	Propagation Delay, CP to $Q_0$ or $Q_7$	3.3	8.5	14.5	21.5	7.0	23.0	ns
	(Shift Left or Right)	5.0	5.5	10.0	14.5	5.0	16.0	
t <sub>PLH</sub> Propag	Propagation Delay, $\overline{CP}$ to $I/O_n$	3.3	9.0	14.5	20.5	7.5	22.5	ns
		5.0	6.0	10.0	14.5	5.0	16.0	
t <sub>PHL</sub>	Propagation Delay, $\overline{CP}$ to I/O <sub>n</sub>	3.3	10.0	16.0	23.0	8.5	24.5	ns
		5.0	6.5	11.0	16.0	6.0	17.5	
t <sub>PHL</sub>	Propagation Delay, $\overline{\text{MR}}$ to $Q_0$ or $Q_7$	3.3	9.0	15.5	22.5	7.5	25.0	ns
		5.0	5.5	10.5	15.5	5.0	17.0	1
t <sub>PHL</sub>	Propagation Delay, MR to I/O <sub>n</sub>	3.3	9.0	15.0	21.5	7.5	24.0	ns
		5.0	5.5	10.0	15.0	5.0	16.5	
t <sub>PZH</sub>	Output Enable Time, OE to I/On	3.3	7.0	12.0	18.0	6.0	19.5	ns
		5.0	4.5	8.5	12.5	4.0	13.5	
t <sub>PZL</sub>	Output Enable Time, OE to I/On	3.3	7.0	12.5	18.0	6.0	20.5	ns
		5.0	5.0	8.0	12.5	4.0	14.0	
t <sub>PHZ</sub>	Output Disable Time, OE to I/On	3.3	6.5	13.0	18.5	5.5	19.5	ns
		5.0	3.5	9.5	14.0	3.0	15.0	
t <sub>PLZ</sub>	Output Disable Time, OE to I/On	3.3	5.5	11.5	17.0	4.5	19.0	ns
		5.0	3.5	8.0	12.5	2.0	13.5	

## Note:

6. Voltage range 3.3 is 3.3V  $\pm$  0.3V. Voltage range 5.0 is 5.0V  $\pm$  0.5V.

				⊦25°C, 50pF	$\label{eq:T_A} \begin{array}{l} T_A = -40^\circ C \text{ to } +85^\circ C, \\ C_L = 50 p F \end{array}$		
Symbol	Parameter	V <sub>CC</sub> (V) <sup>(7)</sup>	Тур.	Gu	aranteed Minimum	Units	
t <sub>S</sub>	Setup Time, HIGH or LOW,	3.3	3.0	8.0	8.5	ns	
	S <sub>0</sub> or S <sub>1</sub> to CP	5.0	2.0	5.0	5.5		
t <sub>H</sub>	Hold Time, HIGH or LOW,	3.3	-3.0	0.5	0.5	ns	
	S <sub>0</sub> or S <sub>1</sub> to CP	5.0	-1.5	1.0	1.0		
t <sub>S</sub>	Setup Time, HIGH or LOW,	3.3	2.0	5.5	6.0	ns	
	I/O <sub>n</sub> to CP	5.0	1.0	3.5	4.0		
t <sub>H</sub>	Hold Time, HIGH or LOW, I/O <sub>n</sub> to CP	3.3	-2.0	0	0	ns	
		5.0	-1.0	1.0	1.0		
t <sub>S</sub>	Setup Time, HIGH or LOW,	3.3	2.5	6.5	7.0	ns	
	DS <sub>0</sub> or DS <sub>7</sub> to CP	5.0	1.5	4.0	4.5	1	
t <sub>H</sub>	Hold Time, HIGH or LOW,	3.3	-2.0	0	0.5	ns	
	DS <sub>0</sub> or DS <sub>7</sub> to CP	5.0	-1.0	1.0	1.0		
t <sub>W</sub>	CP Pulse Width, LOW	3.3	3.5	4.5	5.0	ns	
		5.0	2.0	3.5	3.5		
t <sub>W</sub>	MR Pulse Width, LOW	3.3	4.0	4.5	5.0	ns	
		5.0	2.0	3.5	3.5		
t <sub>REC</sub>	Recovery Time, MR to CP	3.3	0	1.5	1.5	ns	
		5.0	0.5	1.5	1.5		

## Note:

7. Voltage range 3.3 is 3.3V  $\pm$  0.3V. Voltage range 5.0 is 5.0V  $\pm$  0.5V.

			T <sub>A</sub> = +25°C, C <sub>L</sub> = 50pF			$     T_{A} = -40^{\circ}C \\     C_{L} = $		
Symbol	Parameter	V <sub>CC</sub> (V) <sup>(8)</sup>	Min.	Тур.	Max.	Min.	Max.	Units
f <sub>MAX</sub>	Maximum Input Frequency	5.0	120	170		110		MHz
t <sub>PLH</sub>	Propagation Delay, CP to $Q_0$ or $Q_7$ (Shift Left or Right)	5.0	4.0	8.5	12.5	3.0	14.0	ns
t <sub>PHL</sub>	Propagation Delay, CP to $Q_0$ or $Q_7$ (Shift Left or Right)	5.0	4.0	9.0	13.5	3.5	15.0	ns
t <sub>PLH</sub>	Propagation Delay, CP to I/O <sub>n</sub>	5.0	4.5	8.5	12.5	4.5	13.5	ns
t <sub>PHL</sub>	Propagation Delay, CP to I/O <sub>n</sub>	5.0	5.0	9.5	15.0	4.5	16.5	ns
t <sub>PHL</sub>	Propagation Delay, $\overline{\text{MR}}$ to $Q_0$ or $Q_7$	5.0	4.0	14.0	15.0	4.0	18.0	ns
t <sub>PHL</sub>	Propagation Delay, $\overline{\text{MR}}$ to I/O <sub>n</sub>	5.0	4.0	13.0	14.5	3.5	17.5	ns
t <sub>PZH</sub>	Output Enable Time, OE to I/On	5.0	2.5	8.0	12.0	1.5	13.0	ns
t <sub>PZL</sub>	Output Enable Time, OE to I/On	5.0	2.0	8.0	12.0	1.5	13.5	ns
t <sub>PHZ</sub>	Output Disable Time, $\overline{OE}$ to I/O <sub>n</sub>	5.0	2.0	8.5	12.5	2.0	13.5	ns
t <sub>PLZ</sub>	Output Disable Time, $\overline{OE}$ to I/O <sub>n</sub>	5.0	2.5	8.0	11.5	2.0	12.5	ns

### Note

8. Voltage range 5.0 is  $5.0V \pm 0.5V$ .

# AC Operating Requirements for ACT

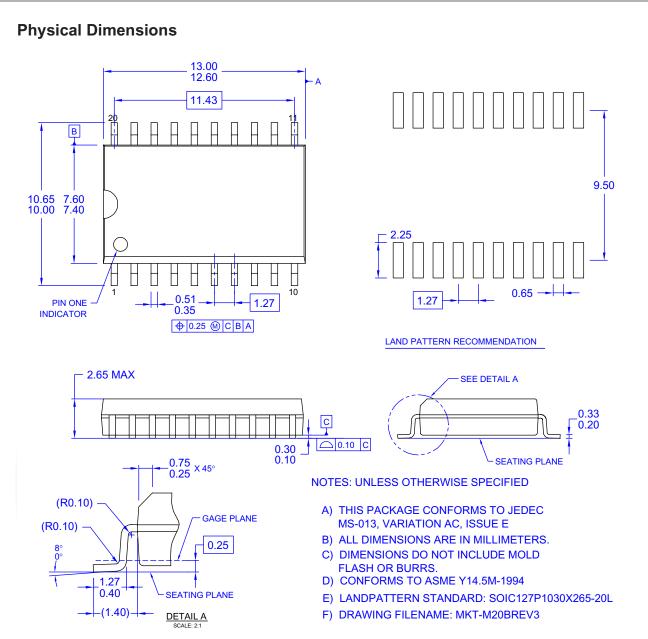
				-25°C, 50pF	$ \begin{array}{l} T_A = -40^\circ C \ to \ +85^\circ C, \\ C_L = 50 pF \end{array} $	
Symbol	Parameter	V <sub>CC</sub> (V) <sup>(9)</sup>	Тур.	Gu	aranteed Minimum	Units
t <sub>S</sub>	Setup Time, HIGH or LOW, $S_0$ or $S_1$ to CP	5.0	2.0	5.0	5.5	ns
t <sub>H</sub>	Hold Time, HIGH or LOW, $S_0$ or $S_1$ to CP	5.0	-2.0	1.0	1.0	ns
t <sub>S</sub>	Setup Time, HIGH or LOW, I/O <sub>n</sub> to CP	5.0	1.5	4.0	4.5	ns
t <sub>H</sub>	Hold Time, HIGH or LOW, I/O <sub>n</sub> to CP	5.0	-1.0	1.0	1.0	ns
t <sub>S</sub>	Setup Time, HIGH or LOW, $DS_0$ or $DS_7$ to CP	5.0	1.5	4.5	5.0	ns
t <sub>H</sub>	Hold Time, HIGH or LOW, $DS_0$ or $DS_7$ to CP	5.0	-1.0	1.0	1.0	ns
t <sub>W</sub>	CP Pulse Width, HIGH or LOW	5.0	2.0	4.0	4.5	ns
t <sub>W</sub>	MR Pulse Width, LOW	5.0	2.0	3.5	3.5	ns
t <sub>REC</sub>	Recovery Time, $\overline{MR}$ to CP	5.0	0	1.5	1.5	ns

Note

9. Voltage range 5.0 is  $5.0V \pm 0.5V$ .

# Capacitance

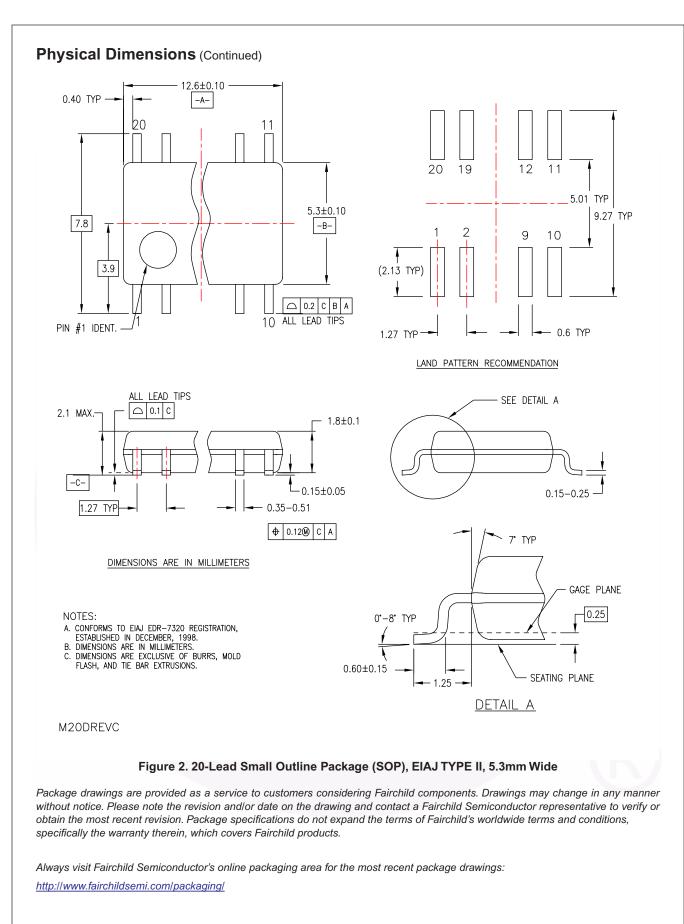
Symbol	Parameter	Conditions	Тур.	Units
C <sub>IN</sub>	Input Capacitance	$V_{CC} = 5.0 V$	4.5	pF
C <sub>PD</sub>	Power Dissipation Capacitance	$V_{CC} = 5.5V$	170	pF

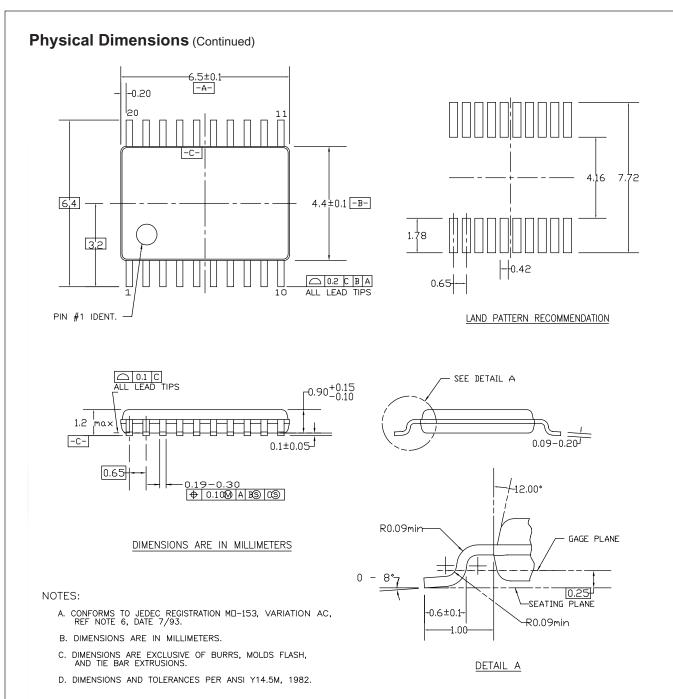


### Figure 1. 20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300" Wide

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# MTC20REVD1

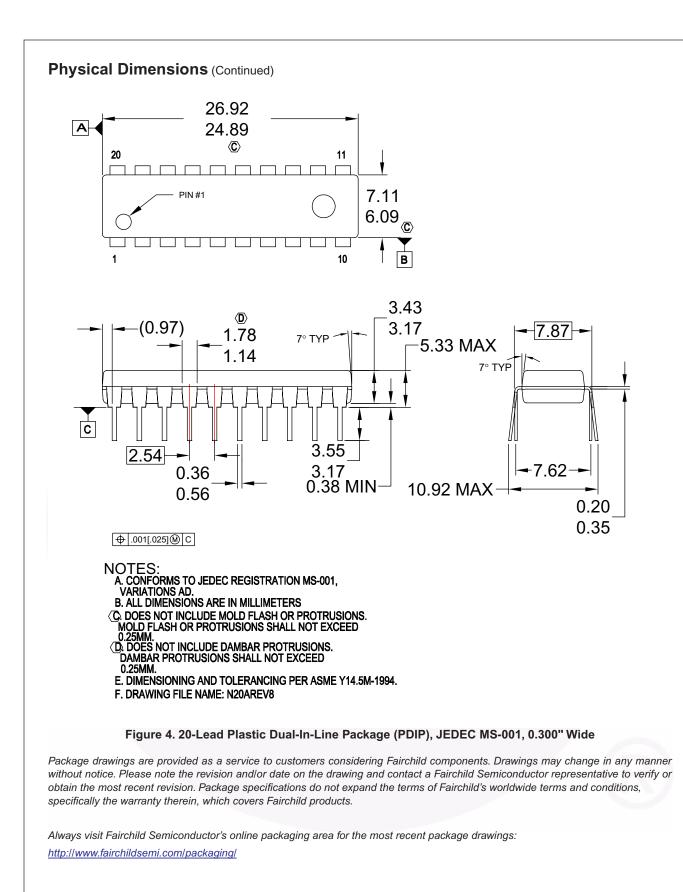
## Figure 3. 20-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide

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74AC299, 74ACT299 — 8-Input Universal Shift/Storage Register with Common Parallel I/O Pins





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